

AON4407-VB Datasheet

P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)		
- 30	0.030 at V _{GS} = - 10 V	- 5.1	5.1 nC		
- 30	0.042 at V _{GS} = - 4.5 V	- 4.1	5.1 IIC		

FEATURES

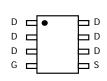
- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET® Power MOSFET

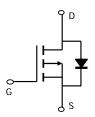
COMPLIANT HALOGEN FREE

APPLICATIONS

· Load Switch







ABSOLUTE MAXIMUM RATIN	I GS T _A = 25 °C,	unless otherwis	e noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 30	V	
Gate-Source Voltage		V_{GS}	± 20		
	T _C = 25 °C		- 5.1		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C		- 4.1		
Continuous Diain Current (1) = 130 °C)	T _A = 25 °C	I _D	- 4.1 ^{b, c}		
	T _A = 70 °C		- 3.3 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	- 20		
	T _C = 25 °C		- 2.5		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 1.67 ^{b, c}		
	T _C = 25 °C		3.0		
Maniana Barras Biasinatian	T _C = 70 °C		2.0	w	
Maximum Power Dissipation	T _A = 25 °C	- P _D	2.0 ^{b, c}	VV	
	T _A = 70 °C		1.3 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R_{thJA}	55	62.5	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	34	41	5/ • •		

Notes:

- a. Based on T_C = 25 °C.
 b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under Steady State conditions is 110 °C/W.

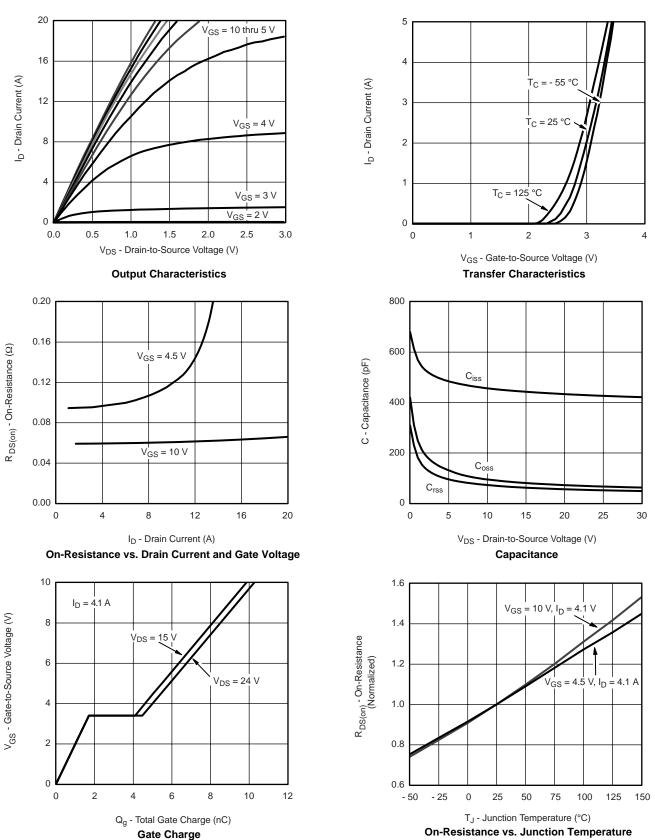


Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	· ·				L		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 250 A		- 31		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		4.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.0		- 3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
7 0 . 1/1 5 . 0	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V			- 1	μΑ	
Zero Gate Voltage Drain Current		V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 V$, $V_{GS} = -10 V$	- 20			Α	
		V _{GS} = - 10 V, I _D = - 4.1 A	0.030				
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 1.0 A		0.042		Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 4.1 A		8		S	
Dynamic ^b				1	<u>I</u>		
Input Capacitance	C _{iss}			450			
Output Capacitance	C _{oss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		80		pF	
Reverse Transfer Capacitance	C _{rss}			63			
Total Gate Charge		V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 4.1 A		10	15	nC	
Total Gate Charge	Qg			5.1	8		
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -4.1 \text{ A}$		1.8			
Gate-Drain Charge	Q_{gd}			2.5			
Gate Resistance	R_{g}	f = 1 MHz		7		Ω	
Turn-On Delay Time	t _{d(on)}			40	60		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 4.6 Ω		80	120	- ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -3.3 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		20	30		
Fall Time	t _f			12	20		
Turn-On Delay Time	t _{d(on)}			5	10		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 4.6 Ω		13	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 3.3 A, V_{GEN} = - 10 V, R_g = 1 Ω		20	30		
Fall Time	t _f			10	15		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 2.5	^	
Pulse Diode Forward Current ^a	I _{SM}				- 20	A	
Body Diode Voltage	V _{SD}	I _S = - 3.3 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			20	30	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 3.3 A, di/dt = 100 A/μs, T _{.1} = 25 °C		20	30	nC	
Reverse Recovery Fall Time	t _a	$_{1F} = -3.3 \text{ A}, \text{ al/at} = 100 \text{ A/}\mu\text{s}, \text{I}_{\text{J}} = 25 ^{\circ}\text{C}$		14			
Reverse Recovery Rise Time	t _b			6		ns	

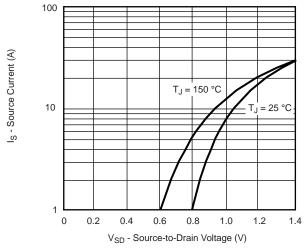
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing.

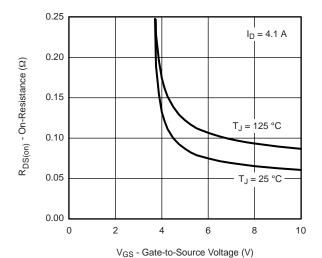
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





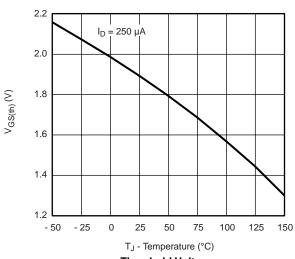


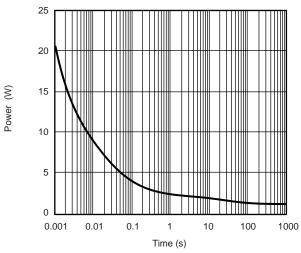




Source-Drain Diode Forward Voltage

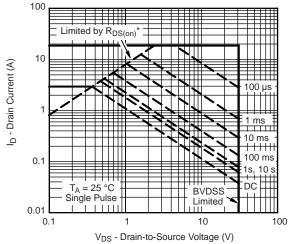






Threshold Voltage

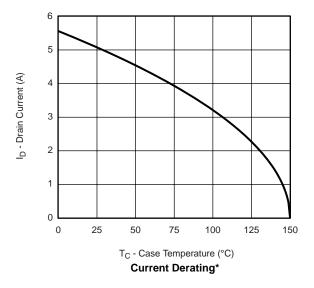
Single Pulse Power

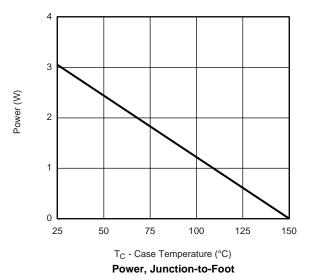


* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified

Safe Operating Area

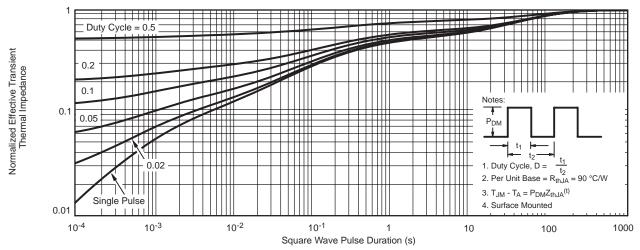




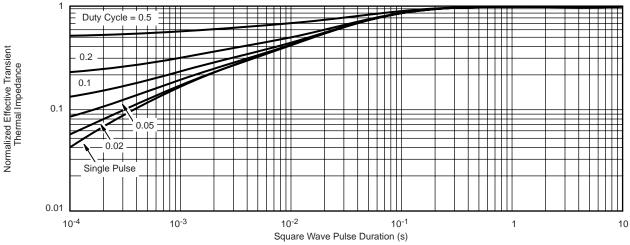


* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

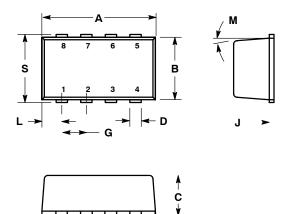


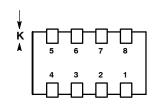
Normalized Thermal Transient Impedance, Junction-to-Foot



PACKAGE DIMENSIONS

ChipFET CASE 1206A-03 ISSUE D





STYLE 2:

- 2. GATE 1
- 4. GATE 2

- 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
 MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
 LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
 DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
 NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIMETERS		INCHES			
DIM	MIN	MAX	MIN	MAX		
Α	2.95	3.10	0.116	0.122		
В	1.55	1.70	0.061	0.067		
c	1.00	1.10	0.039	0.043		
D	0.25	0.35	0.010	0.014		
G	0.65 BSC		0.02	5 BSC		
7	0.10	0.20	0.004	0.008		
K	0.28	0.42	0.011	0.017		
L	0.55 BSC		0.02	2 BSC		
M	5° NOM		5 °	NOM		
S	1.80	2.00	0.072	0.080		



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